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Bib Data Sheet

CONFIRMATION NO. 1810

SERIAL NUMBER 09/765,995	FILING DATE 01/19/2001 RULE	CLASS 382	GROUP ART UNIT 2621	ATTORNEY DOCKET NO. 002187 USA/C03/PDC/WF/DB
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APPLICANTS

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**** CONTINUING DATA *******

THIS APPLICATION IS A CON OF 09/298,501 04/23/1999 PAT 6,178,257
 WHICH IS A CON OF 08/984,558 12/03/1997 PAT 5,982,921
 WHICH IS A CON OF 07/790,871 11/12/1991 PAT 5,699,447

**** FOREIGN APPLICATIONS *******

ISRAEL 96362 11/16/1990
 ISRAEL 99823 10/23/1991

IF REQUIRED, FOREIGN FILING LICENSE GRANTED

** 05/01/2001

Foreign Priority claimed	<input type="checkbox"/> yes <input type="checkbox"/> no	STATE OR COUNTRY ISRAEL	SHEETS DRAWING 40	TOTAL CLAIMS 10	INDEPENDENT CLAIMS 1
35 USC 119 (a-d) conditions met	<input type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after Allowance				
Verified and Acknowledged	Examiner's Signature _____ Initials _____				

ADDRESS

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TITLE

Substrate Defect Detection
 Optical inspection apparatus for defect detection

FILING FEE RECEIVED 710	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:	<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees (Filing) <input type="checkbox"/> 1.17 Fees (Processing Ext. of time) <input type="checkbox"/> 1.18 Fees (Issue) <input type="checkbox"/> Other _____ <input type="checkbox"/> Credit
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